



OPEN

Granularity mediated multiple reentrances with negative magnetoresistance in disordered TiN thin films

Sachin Yadav^{1,2}, R. P. Aloysius^{1,2}, Govind Gupta^{1,2} & Sangeeta Sahoo^{1,2}✉

Granular superconductors are the common examples of experimentally accessible model systems which can be used to explore various fascinating quantum phenomena that are fundamentally important and technologically relevant. One such phenomenon is the occurrence of reentrant resistive states in granular superconductors. Here, we report the observation of multiple reentrant resistive states for a disordered TiN thin film in its temperature and magnetic field dependent resistance measurements, $R(T)$ and $R(B)$, respectively. At each of the peak-temperatures corresponding to the zero-field $R(T)$, a resistance peak appears in the $R(B)$ around zero field which leads to a negative magnetoresistance (MR) region in its surrounding. These low-field negative MR regions appear for both perpendicular and parallel field directions with relatively higher amplitude and larger width for the parallel field. By adopting a granularity-based model, we show that the superconducting fluctuations in granular superconductors may lead to the observed reentrant states and the corresponding negative MR. Here, we propose that the reduction in the density of states in the fermionic channel due to the formation of Cooper pairs leads to the reentrant resistive state and the competition between the conduction processes in the single particle and Cooper channels result into the multiple resistive reentrances.

Granular superconductors offer suitable platforms to explore various intriguing quantum phenomena that are fundamentally important and are also relevant for nano technological applications¹. These materials possess tuneable electronic properties that are mainly governed by the grain size along with the material properties of individual grains^{2,3} and the intergranular coupling between the neighbouring grains⁴. Further, as the granular materials are known to be disordered, the nature of disorder and the properties at the grain boundaries are very important in governing the conduction mechanism^{4,5}. One of the signatures for granular superconductors is the appearance of resistance peak in the zero-field temperature dependent resistance [$R(T)$] measurements above the superconducting transition temperature (T_c)⁶. The enhanced resistance can be associated to electron–electron interaction (EEI) in strong disorder regime^{7–9}, or to weak localization (WL) originating from quantum interference in the weak disorder regime^{7–10}. Furthermore, for a disordered system with relatively large grains and moderately strong intergranular coupling, the superconducting fluctuations (SFs) can also lead to a resistance maximum which is very sensitive to magnetic field with respect to its position and magnitude¹. Among the SFs, there are three major contributions, namely, the Aslamazov–Larkin (AL)¹¹ contribution, Maki–Thompson (MT)^{12,13} contribution and the Density of states (DOS) contribution³ that are significant above the T_c ^{3,14–16}. In the normal phase Above T_c , an enhancement of conductivity occurs due to shunting with a parallel conductive channel formed by the fluctuating Cooper pairs (FCPs). The related contribution, known as Aslamazov–Larkin (AL) contribution, is dominant near the T_c ¹¹. The contribution from the coherent scattering of quasiparticles that are generated by the broken FCPs before losing their phase coherence is known as Maki–Thompson (MT) contribution^{12,13} which can be significant even far from the T_c ¹⁷. Moreover, the contributions arising from Aslamazov–Larkin (AL) and the Maki–Thompson (MT) corrections to the conductivity are positive. Whereas, the DOS correction related to the reduction in density of states in the single-particle spectrum due to the formation of FCPs leads to a negative contribution to the conductivity. Hence, the competition between DOS and the combined effect of AL and MT together can lead to a resistance maximum in the $R(T)$, provided the DOS contribution dominates⁶.

¹CSIR-National Physical Laboratory, Dr. K. S. Krishnan Marg, New Delhi 110012, India. ²Academy of Scientific and Innovative Research (AcSIR), Ghaziabad 201002, India. ✉email: sahoos@nplindia.org

Here, by using conventional granular superconductor, we aim to experimentally probe this regime where the aforementioned counteractive components of SFs may lead to the appearance of resistance maximum in the $R(T)$ measurements. Further with the help of magnetotransport measurements, we intend to investigate the evolution of the resistance maximum with magnetic field and temperature to examine the role of the individual contributions within the SFs in more detail. However, it becomes important to verify and establish the most plausible reason behind the resistance maximum as there are other prominent mechanisms such as EEI and WL that may lead to the similar observations. In this regard, magnetoresistance (MR) measurement is one of the most common ways to distinguish the phenomena EEI and WL^{1,7}. Hence, the present work is mainly focused to probe and monitor the resistance maximum appearing in $R(T)$ for a granular superconductor in the regime where mostly the SFs dominate the transport. For the execution of the same, we have selected granular TiN thin film as the model system through which temperature and magnetic field dependent resistance measurements $R(T, B)$ are carried out.

The resistance peak appearing above T_c in zero-field $R(T)$ leads to a reentrant resistive state for a system which undergoes metal-superconductor transition at low temperature. Reentrant resistive states are experimentally observed in various systems and most of the times, a single reentrant state surrounding a single resistance peak is observed^{4,18–23}. However, the appearances of single as well as double reentrances are also reported at temperature far below the T_c ^{24–27} and/or with the application of magnetic field^{28,29}. In this article, we report the observation of multiple reentrant resistive states in the zero-field $R(T)$ measurements for granular TiN thin film above the T_c . Here, each of the reentrant resistive states is associated with a resistance peak that appears for the temperature range where the contributions from SFs to the conductivity correction are expected to be significant^{30,31}. Under an external magnetic field, the resistance peaks get suppressed as observed in the field dependent $R(T)$ which indicates the EEI might not be the origin behind the observed resistance peaks³⁰. Further, magnetic field dependent resistance $R(B)$ measurements, carried out in both perpendicular and parallel field directions, also feature multiple reentrances that evolve with temperature. Precisely, a resistance peak leading to negative MR appears around zero-field in the $R(B)$ isotherms for each of the temperature points (T_{peak}) that correspond to resistance peaks in the zero-field $R(T)$.

Negative MR at the peak temperature has been reported for short aluminium wire within only few Oe for the case of a single reentrance¹⁸. However, the field extent for the negative MR region is much higher here. Further, for strongly disordered superconducting thin films at $T \ll T_c$ and at high field, electron–electron interaction mediated negative MR appears at the vicinity of the magnetic field induced superconductor insulator quantum transition (SIT)^{32–34}. For example, the observation of resistance peak in $R(T)$ and negative MR have been reported in strongly disordered superconducting thin films of $a\text{-InO}$ ³⁵, TiN^{28,36}, Pb³⁷, Al-Ge³⁸, NbTiN³⁹ at very low temperature and high magnetic field. At $T < T_c$, negative MR around zero field appeared also for amorphous InO nanowires⁴⁰ and crystalline Mo₂C flakes⁴¹. Most of these cases, the granularity is explained as the origin of the observed negative MR where the Josephson coupling strength between individual superconducting grains competes with other relevant energies related to Coulomb interaction and finite size effects that are significant at low temperature for relatively smaller grain size in strong disorder limit^{38,42}.

However, the negative MR around zero-field here is observed for moderately large grains in the weak disorder regime at temperature above the T_c and at low field range. Generally, WL can be accounted for the observed negative MR where the amplitude and the width of the MR peak strongly depend on the temperature⁴³. For WL, the amplitude increases by lowering temperature and the width gets broadened with increasing temperature⁴⁴. Nevertheless, the correction to the resistance due to WL is significantly low and it is of the order of 0.001 to 0.01⁴³. In contrary to the WL scenario, here for any particular field orientation, the widths of these negative MR peaks remain the same for all the peak temperatures, whereas, their amplitude decreases with decreasing temperature. This indicates the influence of SFs in the appearance of negative magnetoresistance near zero-field rather than the influence of WL. Moreover, the amplitude and the width for the MR peaks appear to be stronger in the parallel field than that for the perpendicular direction which again rules out the possibility of WL being the cause of the observed reentrance and the corresponding negative MR⁴³. Therefore, the most plausible origin of the observed reentrant states can be the SFs where the competition between the negative contribution from the DOS correction and the positive contribution from AL and MT corrections to the conductivity may lead to the development of the observed resistance peaks in the zero-field $R(T)$. Furthermore, by using a granularity-based model, we have illustrated that the observed multiple resistive reentrant states can be originated by the SFs^{6,42}.

Results

First, we present the zero-field $R(T)$ measurements of sample SS2 in Fig. 1. The full-scale $R(T)$ measured from room temperature down to 1 K is presented in Fig. 1a which shows a metallic behaviour with positive dR/dT at high temperature and an upturn with negative dR/dT accompanying a resistive peak at low temperature. The crossover from the positive to negative dR/dT occurs at the characteristic temperature $T_{\text{dip}} \sim 38$ K which is shown by the dashed vertical line in the inset of Fig. 1a. For $T < T_{\text{dip}}$, the resistance increases smoothly with decreasing temperature before a sudden upward jump in the resistance occurs which leads to resistance peak and the associated re-entrance by further lowering temperature.

We highlight the peak region and its immediate surroundings in Fig. 1b which defines three reentrant regions based on the observed three resistance peaks before transiting to the superconducting (SC) state. The peak positions are shown by the black upward arrows and the slope dR/dT changes its direction/sign at each of the peak temperature (T_{peak}) points. The steep positive slope at temperatures below the Reentrance-3 region indicates the dominating role of the fluctuating Cooper pairs and hence the region is named as SF. The region between T_{dip} and the Reentrance-1 corresponds to the quantum corrections to the conductivity (QCC) regime. Further, $R(T)$ measurements carried out under perpendicular magnetic field are shown in Fig. S1 in the Supporting Information

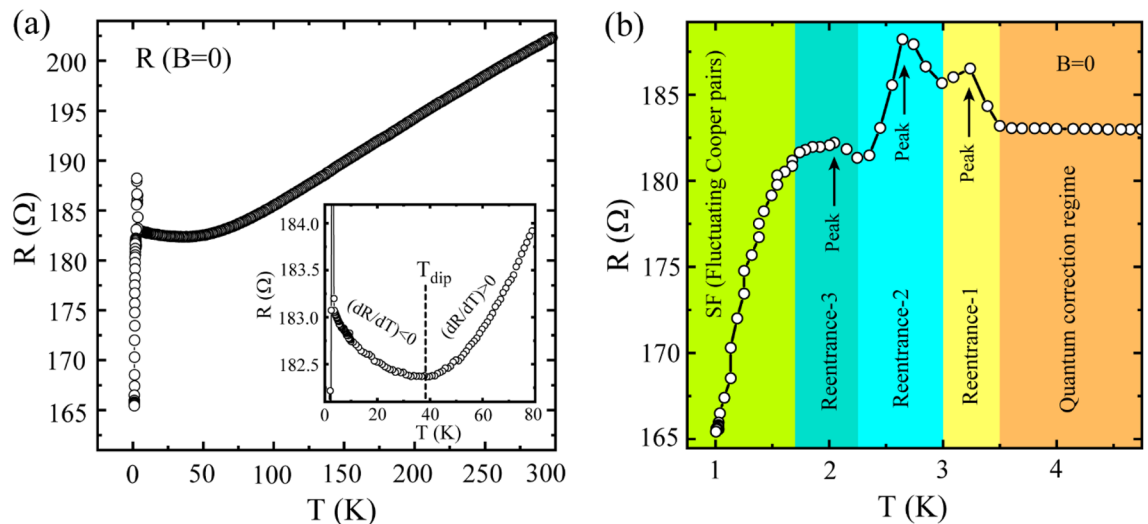


Figure 1. Temperature dependent resistance $R(T)$ measurements. **(a)** Full-scale $R(T)$ measurements under zero-field cooling down from room temperature to 1 K. Inset: A selected portion of the main panel is highlighted to show a resistance minimum at particular temperature (T_{dip}) which eventually separates the negative and the positive dR/dT regions in the zero-field $R(T)$. **(b)** Different reentrance regions associated with the resistive peaks along with the superconducting fluctuations (mainly AL and MT contributions) regime and quantum corrections regime have been marked and highlighted in the low temperature zero-field $R(T)$.

(SI), where the resistive peaks get suppressed under the application of the field. This indicates towards WL and/or SFs as the possible mechanism(s) behind the upturn accompanying the resistive peaks.

Next, in Fig. 2, we present isothermal $R(B)$ measurements carried out under perpendicular magnetic field. A set of $R(B)$ isotherms measured at temperature between 300 mK and 3.5 K is displayed in Fig. 2a. From 300 mK up to 1.5 K, initially the resistance changes with a steep continuous positive slope up to a certain characteristic field above which the $R(B)$ exhibits a non-trivial oscillatory/wavy type feature before merging onto the normal state (NM). For the $R(B)$ isotherm measured at 300 mK, the characteristic field is ~ 1 T, above which the resistance follows a wavy path with a couple of grooves before reaching to the NM. For an insight into the oscillatory part, in Fig. 2b, we have subtracted the measured $R(B)$ from an interpolated background which would likely be followed by the $R(B)$ in absence of the observed bouncy features. For a representative $R(B)$ data measured at 300 mK, the red solid curve in the inset of Fig. 2b presents the background which indeed follows the $R(B)$ data except for the wavy part. This extra feature ΔR , as obtained after background subtraction, is shown in Fig. 2b for the temperature from 300 mK up to 1.5 K. The horizontal cyan line refers to the reference background with $\Delta R = 0$. At 300 mK, the non-zero ΔR appears only below this reference line for $1.1 \text{ T} \leq B \leq 2.7 \text{ T}$ and its maximum value is about $\sim 4.8 \text{ } \Omega$. With increasing temperature, the maximum amplitude of ΔR gets reduced and the feature moves towards lower field with reduced extent in field. At 1.5 K (the blue curve in Fig. 2b), some part goes above the background line before merging onto the NM. Further at higher temperature, the overall change in resistance is small and the extra features overlap with each other in the temperature evolution of the $R(B)$ and for clarity, they have been presented separately in Fig. 2c,d.

A set of $R(B)$ isotherms for $T \geq 1.5 \text{ K}$ and for $-2 \text{ T} \leq B \leq 2 \text{ T}$ is shown in Fig. 2c and for a clearer view, only the positive field side is presented in Fig. 2d. The wavy part, gets more prominent with increasing temperature and the segment appearing above the normal state grows in resistance. For example, at 2.25 K, a very tiny region of $R(B)$ close to zero-field remains underneath the NM and the majority of the $R(B)$ goes above it with a combination of positive and negative magnetoresistance regions before merging onto the NM. And for $T \geq 2.75 \text{ K}$, the nonmonotonic feature in $R(B)$ stays fully above the NM and with increasing temperature, it moves towards the zero-field. For a quantitative analysis, we define the difference between the R_N and the maximum resistance appearing above the NM as δR (shown in Fig. 2d for the representative $R(B)$ measured at 1.75 K). With increasing temperature, δR increases and attains the maximum value at 2.75 K which is exactly the same temperature where the zero-field $R(T)$ shows the maximum resistance as shown in Fig. 1.

In Fig. 3, a set of $R(B)$ isotherms measured under the field applied parallel to the current direction is shown in different representations. The $R(B)$ isotherms for $1 \text{ K} \leq T \leq 3.5 \text{ K}$ are shown in Fig. 3a where similar type of wavy features are observed as that appeared for the perpendicular field. Eventually, with increasing temperature, the overall $R(B)$ curves move towards the NM at around $183 \text{ } \Omega$ as represented by the horizontal magenta curve measured at 3.5 K. While increasing temperature from 1.0 to 2.0 K, the first kink (shown by the arrow in Fig. 3a) moves towards lower field and eventually, leads to a resistance peak (negative MR) around zero-field which is just opposite to the observed dip (positive MR) for the isotherm measured at 1 K. Hence, crossover from positive to negative MR around zero-field is observed with increasing temperature. With further increasing temperature, the rest of the kinks evolve with temperature in a similar fashion and the $R(B)$ isotherms start to appear above the NM. For a detailed insight, this whole set of $R(B)$ isotherms is split into two subsets; one appears below and the other one is above the normal state as shown in Fig. 3b,c, respectively. The negative MR peak around zero-field

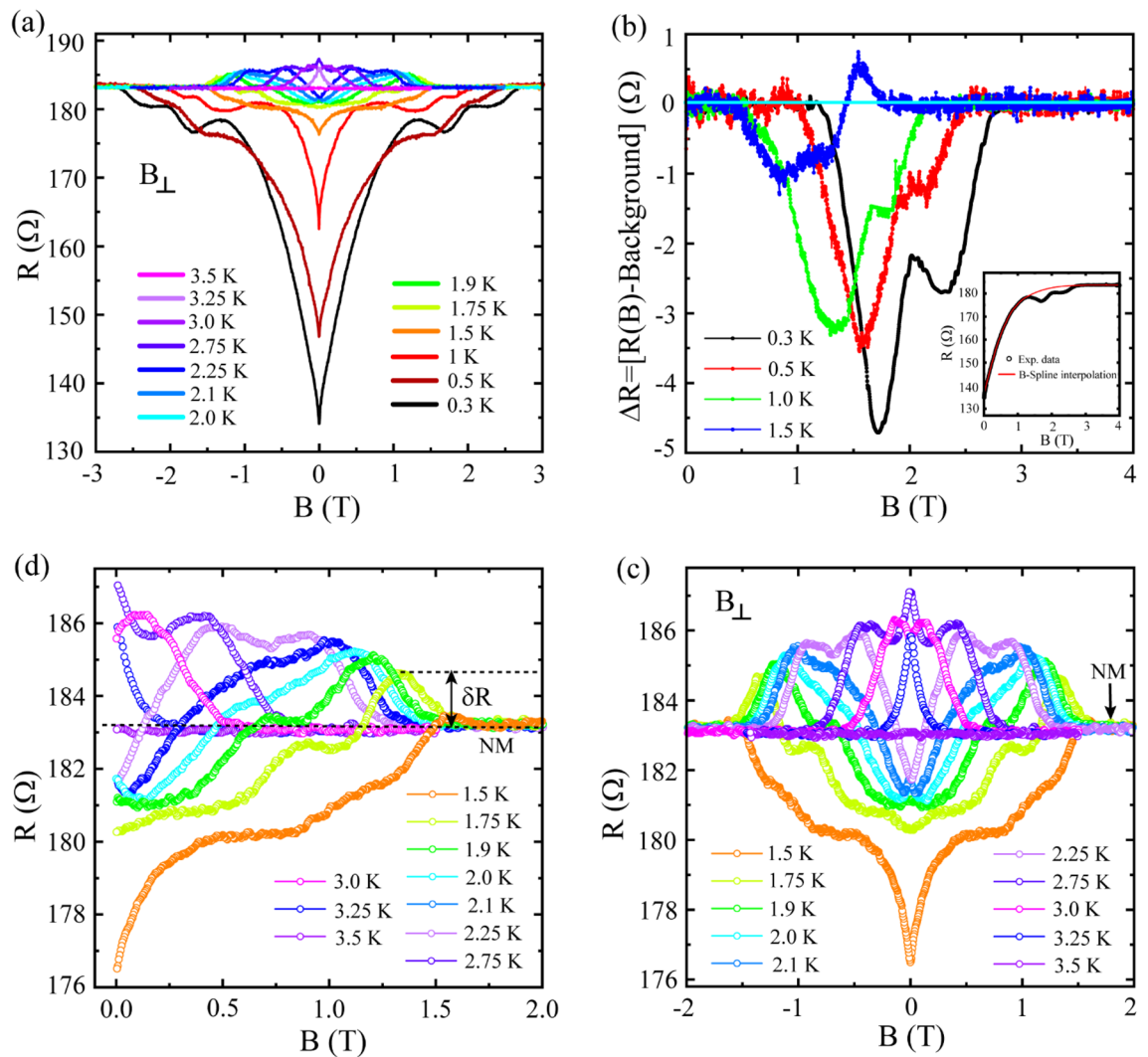


Figure 2. Magnetotransport measurements. (a) Magnetic field dependent resistance $R(B)$ isotherms measured under perpendicular magnetic field. The $R(B)$ isotherms measured in the temperature range from 300 mK up to the Reentrance-1 zone which ends at 3.5 K. (b) ΔR , representing the nonmonotonic oscillatory part embedded in the $R(B)$, obtained by subtracting a B-Spline interpolated background from the experimental $R(B)$ isotherms. Inset: The interpolated background (the red curve) along with the experimental data (the black curve) for a representative $R(B)$ isotherm measured at 300 mK. The details about the interpolated background are explained in the main text. The horizontal cyan line at $\Delta R=0$ indicates the overlapping of the background with the measured $R(B)$. (c) A selective set of $R(B)$ isotherms measured in the temperature window spanning over the reentrance regions. (d) The same set of $R(B)$ as presented in (c) but with only positive side of the B -axis for clarity.

at 2.0 K is clear from Fig. 3b. It should be noted that the third peak at the centre of the Reentrance-3 regime in the zero-field $R(T)$ (Fig. 1b) appears also at 2.0 K.

The top part from Fig. 3a is displayed in Fig. 3c where the temperature evolution of the $R(B)$ isotherms features two common resistive steps with the resistance values of $\sim 187.70 \Omega$ and $\sim 186 \Omega$ as shown by the horizontal dashed black lines above the NM. Interestingly, these two specific resistance values closely match with the resistance values for the 2nd peak from the Reentrance-2 and the 1st peak from the Reentrance-1 region in the zero-field $R(T)$ Fig. 1b. Besides, the $R(B)$ isotherms for $2.4 \text{ K} \leq T \leq 3.0 \text{ K}$ in Fig. 3c feature both positive and negative MR segments that evolve with the temperature. At 3.25 K, only a resistance peak around zero-field appears which indicates the presence of negative MR only. Finally, at 3.5 K, no traceable MR is observed and the $R(B)$ isotherm shown by the magenta horizontal curve overlaps with the NM. For clarity, in Fig. 3d, the $R(B)$ isotherms altogether is shifted linearly with temperature in the upward direction. Evidently, with increasing temperature, the wavy features in the $R(B)$ isotherms move systematically towards lower field and finally the features converge at zero field for 3.25 K. Further, the temperature evolution of individual features is presented in detail in Fig. S2 in the SI.

Next in Fig. 4, we compare the MR measurements for perpendicular and parallel field orientations. In this regard, $R(B)$ isotherms for the temperature range covering the Reentrance-3 regime (Fig. 1b) are considered

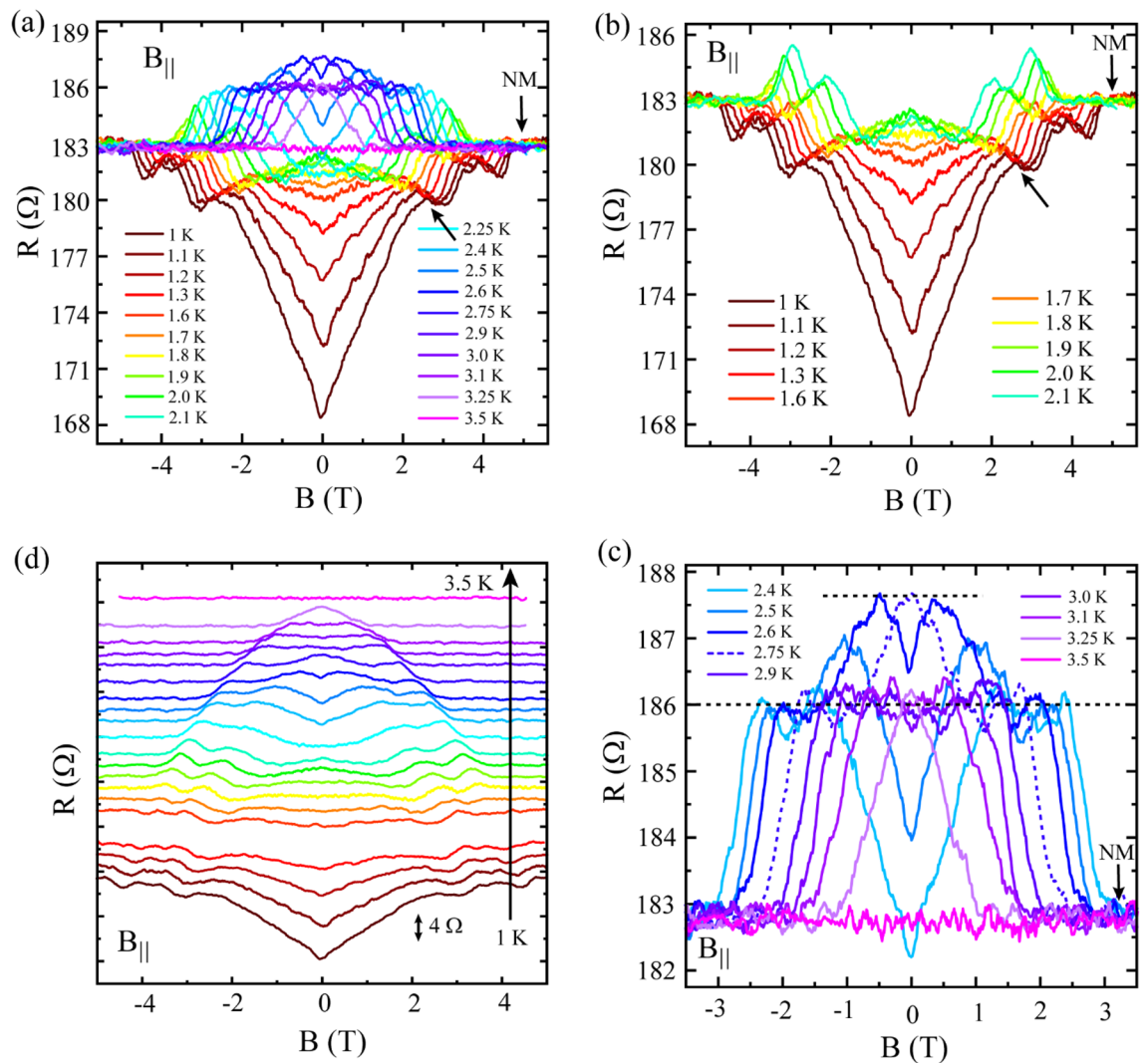


Figure 3. Magnetoresistance measurements under parallel magnetic field. (a) $R(B)$ isotherms measured in the temperature window of 1 K to 3.5 K. Similar to perpendicular field, $R(B)$ characteristics under parallel field also showcase oscillatory pattern containing multiple kink type of features that evolve with temperature. The horizontal curve related to $R(B)$ measured at 3.5 K represents the normal state. The two parts below and above the normal state from (a) have been presented in (b) and (c), respectively. (d) The same set of $R(B)$ isotherms shifted linearly with temperature in the upward direction for clarity. The bottom curve measured at 1 K represents the original device resistance.

in Fig. 4a,b for perpendicular and parallel field orientations, respectively. The peak around zero-field starts to appear at 1.9 K. With increasing temperature, the peak gets prominent and finally, it converts into a dip at 2.25 K for both the field orientations. However, the amplitude and the width of the peak differ for perpendicular and parallel fields. One-to-one comparison of $R(B)$ isotherms measured at the same temperature for parallel and perpendicular field directions is presented in Fig. S3 in the SI. More specifically, at each T_{peak} , the peak around zero-field appears with higher amplitude and larger width for parallel field than that for perpendicular field. Here, we compare three specific $R(B)$ isotherms measured at three peak temperatures 3.25 K, 2.75 K and 2.0 K, in Fig. 4c,d for perpendicular and parallel field orientations, respectively. The number of resistance peaks changes from $3 \rightarrow 2 \rightarrow 1$ for changing the temperature from 2.0 K \rightarrow 2.75 K \rightarrow 3.25 K for both the field orientations. Similar to the peak at 2.0 K (Fig. 4a,b), the amplitude of the peak around zero-field for 2.75 K or 3.25 K is more prominent for parallel field than that for the perpendicular orientation. Interestingly, for any particular field direction, all the three zero-field MR peaks measured at these three specific peak temperatures are almost of the same width as indicated by the black vertical dotted lines in Fig. 4c,d. Generally, negative MR originated due to WL strongly depends on temperature and with increasing temperature, the peak width broadens up while the peak amplitude decreases. Therefore, WL alone might not be the origin of the negative MR here.

Nevertheless, we have calculated MR (%) [MR (%) = $\frac{R(B) - R(0)}{R(0)} \times 100$, where $R(0)$ is zero-field resistance] and for a set of representative isotherms measured under perpendicular field the MR (%) is shown in Fig. S4 in the SI, which defines the positions of various resistance peaks, normal state and the maximum MR state. In the studied range of temperature, MR (%) shows an oscillatory type of behaviour with decaying amplitude

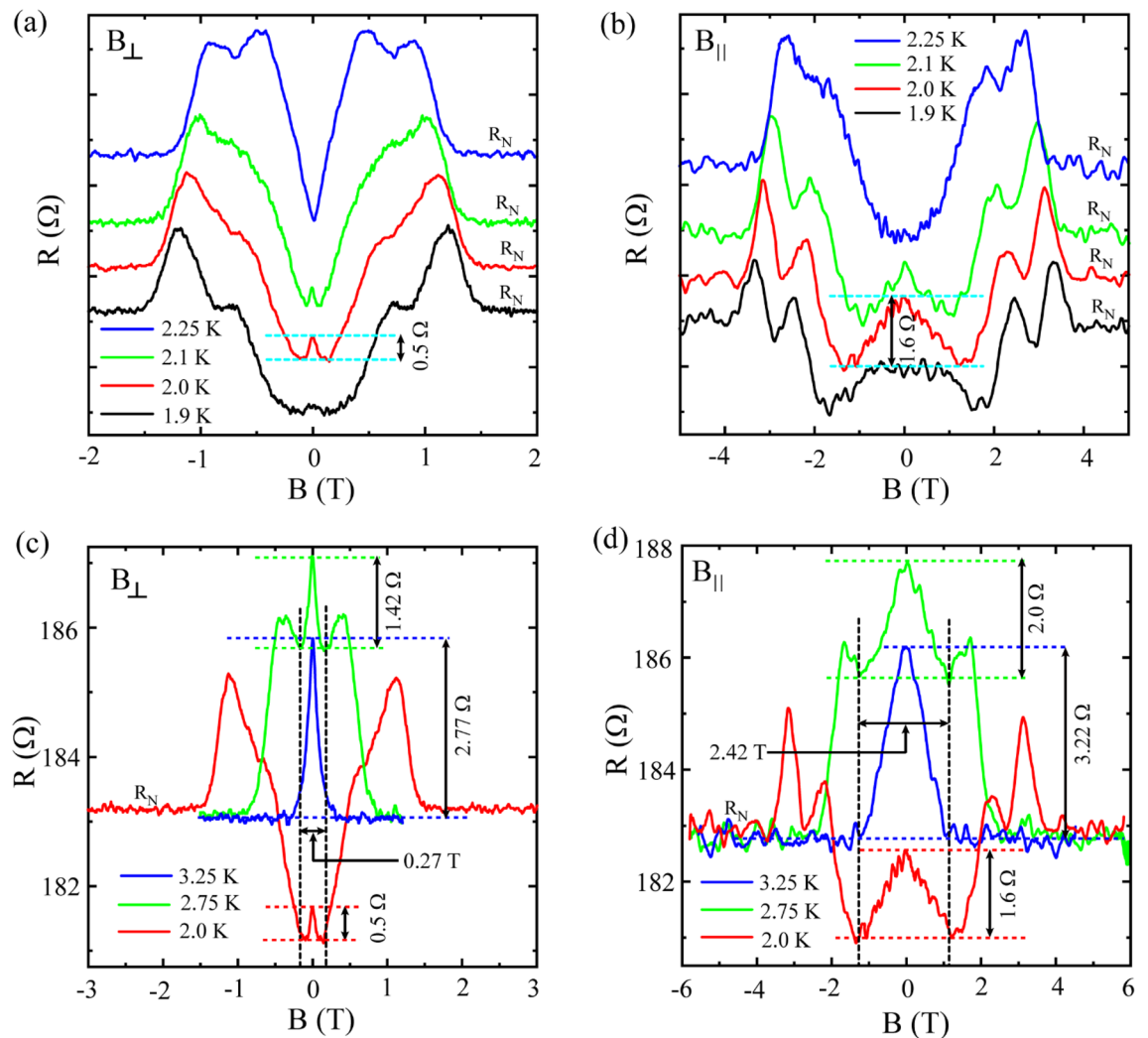


Figure 4. Comparison of $R(B)$ isotherms for parallel and perpendicular magnetic field orientations. Selective sets of isotherms for perpendicular field (a,c) and for parallel field (b,d). (a,b) $R(B)$ isotherms from Reentrance-3 region shifted linearly with temperature in the upward direction for clarity and the bottom black curve measured at 1.9 K represents the original sample resistance. (c,d) Isotherms displaying negative magnetoresistance by accompanying a resistance peak around zero-field. The corresponding temperature values match with the peak positions in the zero-field $R(T)$ data. Further, the peak resistance at $B=0$, as obtained from the $R(B)$ isotherms, follows the same trend as it appeared in the zero-field $R(T)$. For example, the maximum resistance occurs for the peak at 2.75 K which matches exactly with the value that appeared in the zero-field $R(T)$ at the same temperature.

for higher temperature (Fig. S4b,c). The corresponding field-temperature dependence for all the characteristic states are shown in Fig. S5 in the SI for both the field orientations. Further, we observe that the excess resistance ' δR ' (defined as the difference in the maximum resistance above the NM and the R_N as shown in Fig. 2d) varies with temperature in a similar fashion as that of the zero-field $R(T)$ and the comparison is presented in Fig. S4d. The appearance of peaks in temperature dependent ' δR ' at the same temperature as that appeared in zero-field $R(T)$ and also the similar pattern of amplitude modulation of ' δR ' and zero-field $R(T)$ indicate that the same mechanism is responsible behind the appearance of peak structures in both $R(T)$ and $R(B)$.

Discussion

The zero-field $R(T)$ measurements in a disordered TiN thin film above the T_c exhibit multiple resistive reentrant states and the associated resistance peaks get suppressed under perpendicular magnetic field. This implies a negligible contribution from the EEI towards the observed resistance up-turn and the associated re-entrance. Further, the temperature evolution of the low-field MR peaks with respect to their amplitude, width and the field orientation indicates that WL cannot be accounted fully for the observed reentrant states^{43,45}. As the sample appears to be granular in nature (Fig. S8), SFs might be the most plausible mechanism responsible for the observed reentrant states and the associated negative MR^{37,46,47}. In this scenario, the Cooper pairs are localized in individual grains and the conduction is mainly led by the single particle conduction channel.

The manifestation of SFs in the normal phase of a superconductor occurs directly by opening a parallel shunting channel due to the formation of fluctuating Cooper pairs (FCPs) above the T_c which is known as the AL contribution¹¹. On approaching the T_c , it can be expressed in terms of the reduced temperature $\epsilon \equiv \ln\left(\frac{T}{T_c}\right) \approx \frac{T-T_c}{T_c} \ll 1$ in 2D with thickness d as³,

$$\sigma^{AL}(T) \sim \frac{e^2}{\hbar d} \frac{1}{\epsilon} \quad (1)$$

Besides, there are two major indirect contributions of the SFs on the quasiparticle subsystem, namely, the MT and the DOS contributions that are significant above the T_c . The former is relevant in the dirty limit and close to the T_c where the coherent scattering of FCPs with impurities leads to an increase in the conductivity in the normal phase of the single particle channel. In 2D, the MT contribution can be expressed as³,

$$\sigma^{MT}(T) \sim \frac{e^2}{8\hbar} \frac{1}{\epsilon} \ln \frac{\tau_\phi}{\tau_{GL}} \quad (2)$$

With the Ginzburg–Landau relaxation time $\tau_{GL} = \frac{\pi\hbar}{8k_B(T-T_c)}$. Here, the dephasing time $\tau_\phi = \frac{\pi\hbar}{8k_B T} \frac{1}{\delta}$ introduces phase breaking processes due to mainly inelastic scattering with the pair breaking parameter δ ^{17,48}.

The DOS contribution originating from the depletion of quasiparticles for the formation of FCPs is given by³,

$$\sigma^{DOS}(T) \sim -\frac{e^2}{\hbar} \ln \frac{1}{\epsilon} \quad (3)$$

From Eqs. (1)–(3), the AL and MT contributions are positive, whereas, there is a negative sign in front of the DOS contribution. Here, the suppression in the DOS for the single particle channel results into increased resistance^{23,49,50}. Further on approaching the T_c , the AL and MT terms are singular in temperature whereas, the DOS shows relatively weaker dependence on temperature as evident by the slow varying logarithmic dependence of the temperature. At T close to T_c , AL and MT dominate. MT contributions can be significant at temperature far from the T_c also, however, as it is very sensitive to the phase breaking processes, it can be suppressed by the application of magnetic field^{6,17}. A little far from the T_c , DOS can be significant and it can compete with the combined contributions from the AL and MT terms³. With dominating DOS contribution, resistance maximum can appear at higher temperature. Under the application of magnetic field, MT gets suppressed and the resistance maximum is expected to move towards lower temperature with reduced amplitude^{6,30} as observed in the present study.

For zero-field $R(T)$ measurements while approaching the T_c from higher temperature, formation of more number of FCPs leads to more reduction in the DOS which may create a pseudogap for the single particle spectrum⁴⁹ and resistance continues to increase. Finally, at certain temperature, a resistance maximum is reached. Further lowering temperature, the superconducting grains in the close proximity combine with each other through Josephson coupling and form superconducting puddles. Here, the contribution from Cooper channel starts to dominate over the single particle channel and resistance continues to drop and at certain characteristic temperature, the superconducting puddles combine altogether and macroscopic phase coherence is established^{25,51}. The above situation refers to a single resistive reentrance. However, if the grains are not of uniform dimension all through the sample, there might be multiple reentrances originating from opening and blocking of percolation paths for the localized cooper pairs^{25,26}. In this case, for a certain range of temperature, one contribution wins and in the next range of temperature, the other takes over^{6,25,27}.

In order to understand the observed reentrant resistive states by using the granular model based on SFs, we have replotted the selective region of the zero-field $R(T)$ in Fig. 5a with each reentrant regime in two sub-regimes based on an upward ($dR/dT > 0$) or downward ($dR/dT < 0$) slopes. Accordingly, the six sub-regimes, marked in ascending order from high to low temperature direction, are explained schematically by the granular model in Fig. 5b–g. As the region-I leads to the first resistance maximum, Fig. 5b suggests the reduction in conduction electrons due to the formation of few scattered FCPs that are confined in the cyan grains. Resistance continues to increase while lowering the temperature as a greater number of electrons get occupied for the FCP formation. With lowering temperature, local superconductivity is established inside these grains and the neighbouring superconducting grains start to couple with each other by Josephson coupling and FCPs start to tunnel from one grain to the other. This leads to a reduced resistance with $dR/dT > 0$ in the region II as shown in Fig. 5c. By further lowering the temperature to region-III, resistance reaches to its maximum value which indicates the rate of formation of FCPs is much more than the rate of coupling between them. The scenario is presented in Fig. 5d which shows a greater number of FCPs but coupling between them is yet to be established. However, by continuously reducing the temperature, localized superconducting grains start to couple with each other and contribute to the conduction and resistance drops in region-IV (Fig. 5e). At this stage, the competition between the Cooper pair channel and the quasiparticle channel becomes almost comparable and with further lowering temperature some more quasiparticles move from single particle channel to form FCPs (Fig. 5f) and in region-V, only a little enhancement in resistance is observed. And finally, in region-VI, the neighbouring superconducting grains couple together to form superconducting puddles of much bigger size. With lowering the temperature, these big superconducting puddles couple with each other by Josephson coupling and the conduction is dominated by the Cooper pairs channel in region-VI as shown in Fig. 5g.

Apart from the appearance of reentrant resistive states in the zero-field $R(T)$, a resistance peak appears in the $R(B)$ isotherm around zero field for each of the peak temperatures (T_{peak}). This leads to a negative MR ($dR/dB < 0$) region at low field range much lower than the critical field. At the resistance maximum, with the application of magnetic field, the Cooper pairs break into quasiparticles and conductance increases in the single-particle

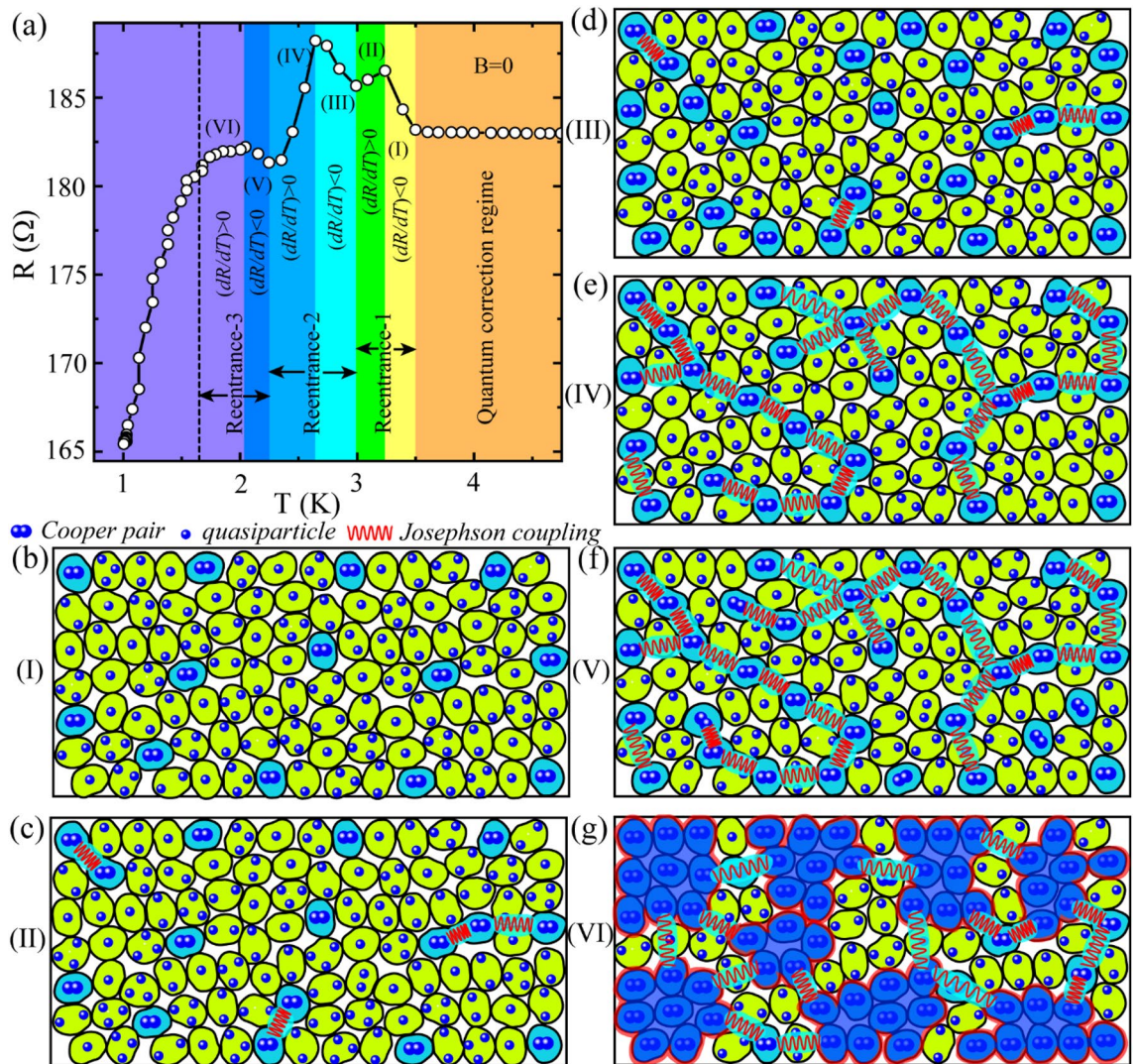


Figure 5. A granularity model has been adopted to explain the reentrant behaviour in $R(T)$. (a) $R(T)$ is fragmented into 6 different regions marked by shaded vertical columns on the basis of sign of dR/dT from metallic state (orange shade) to superconducting state (violet colour). Further, these 6 regions are explained by using the granularity model in (b)–(g), where blue and light green grains are in superconducting (Cooper pairs) and metallic states (quasiparticles), respectively. The red zig-zag lines mark the Josephson coupling between the superconducting grains.

channel. This explains the observed negative MR at the peak temperature T_{peak} . However, the width of the MR peaks for parallel field is more than that appears for the perpendicular field. This might be due to the stronger detrimental effect for perpendicular field on superconducting pairing and fluctuations than that usually occurs in parallel field^{45,52,53}. However, the reason behind the higher amplitude for the negative MR peaks for the parallel field than that occurred for the perpendicular field is not clear and it needs further investigation for clear understanding.

Conclusion

In conclusion, two-dimensional granular superconducting TiN thin film demonstrates the experimental observation of multiple reentrant resistive states above its transition temperature T_c . The zero-field resistance peaks corresponding to each reentrance lead to low field negative magnetoresistance in the $R(B)$ isotherms. With the help of low temperature magnetotransport measurements carried out under parallel and perpendicular magnetic field, we show that the origin of the reentrant state lies majorly on the superconducting fluctuations (SFs). The negative MR peaks around zero-field are much more pronounced in the parallel field than that in the perpendicular field direction. Further, it is observed that the widths of these low-field MR peaks remain unaltered with the temperature while their amplitude increases with increasing temperature. We have proposed a granularity-based model on SFs to explain the observed multiple reentrant states that are mainly formed by the competition among different contributions from SFs. The proposed model is able to explain all the observed features and phenomena in the $R(T)$ and $R(B)$ measurements except for the enhanced amplitude for the MR peaks

with increasing temperature. Further study particularly theoretical modelling would be helpful to understand the evolution of the resistance peaks with temperature and the magnetic field direction.

Methods

Thin film growth process

We have used undoped Si (100) substrate covered with Si_3N_4 dielectric spacer layer of 80 nm thickness. The Si_3N_4 topping layer was grown by using low pressure chemical vapor deposition (LPCVD) technique and in this study, Si_3N_4 is the only source of nitrogen for the nitridation of Ti to produce TiN thin films^{54–56}. After following up the standard cleaning process of the substrates, Ti films were deposited on the substrate by dc magnetron sputtering using a Ti target of 99.995% purity in the presence of high purity Ar (99.9999%) gas. Sputtering of Ti was performed with a base pressure less than 1.5×10^{-7} Torr. Finally, the sputtered samples were transferred in situ to an UHV chamber attached to the sputtering chamber for annealing which was done at ~ 780 °C for 2 h in a high vacuum condition with pressure less than 2×10^{-7} Torr. It is noteworthy to mention that the annealing pressure here is much higher than the pressure ($< 5 \times 10^{-8}$ Torr) maintained during the annealing for the samples presented in our previous reports^{30,55}. Hence, oxygen content in the present batch is expected to be more and it may have significant influence on the transport properties of the sample. The X-ray photoelectron spectroscopy (XPS) analysis carried out on a reference sample (which was placed in the closest proximity of the sample SS2 and grown in the same batch) confirms the presence of oxygen in the sample. The detailed interface studies through XPS characterization are presented in Fig. S7 in the Supporting Information (SI).

Low temperature transport measurements

For low temperature transport measurements, the thin films were grown into a Hall bar geometry by using the stainless-steel shadow mask. Further, electrical contact leads of Au (80–100 nm)/Ti (5 nm) were deposited by dc magnetron sputtering by using a separate complimentary mask. The dimensions of the sample presented in this study were of 1100 μm length and 500 μm width. The thickness of the film is (6 ± 1) nm which is well below the Ginzburg–Landau coherence length $\xi_{GL}(0)$ of about 10 nm as obtained from the upper critical field B_{c2} and the same is presented in Fig. S6 in the SI.

Low temperature transport measurements were carried out in dilution refrigerator by Oxford Instruments with base temperature 20 mK and equipped with superconducting magnet for magnetic field up to 14 T. For $R(T)$ measurements, the conventional 4-probe configuration was adopted by using standard Lock-In technique with 100 nA excitation at 17 Hz frequency. Here, model 7265 from Signal Recovery is used as the Lock-in amplifier. Further, a low noise voltage preamplifier (Signal Recovery 5113) was used to record the voltage signal.

Structural characterizations

For surface morphological characterization, we have used atomic force microscope (AFM) (Multimode V, NS V, Veeco) in tapping mode. X-ray Photoelectron Spectroscopic (XPS) measurements were performed in UHV based Multiprobe Surface Analysis System (OMICRON, Germany) operating at a base pressure of 5×10^{-11} Torr. A monochromatic Al-K α radiation source (1486.7 eV) was employed for data acquisition which was calibrated against C (1s) core level at 284.8 eV. The calibration of work function of the system and the binding energy in photoemission spectra was carried out referring to Au 4f_{7/2} emission line and Au Fermi level. To enhance the sampling depth and minimize the contribution of native oxides and contaminants, in situ sputtering via energetic Ar⁺ ions (at 2 keV) was performed.

Data availability

The data that represent the results in this paper and the data that support the findings of this study are available from the corresponding author upon reasonable request.

Received: 6 September 2023; Accepted: 15 December 2023

Published online: 20 December 2023

References

1. Beloborodov, I. S., Lopatin, A. V., Vinokur, V. M. & Efetov, K. B. Granular electronic systems. *Rev. Mod. Phys.* **79**, 469–518 (2007).
2. Perkins, D. T. S., Klemencic, G. M., Fellows, J. M. & Smith, R. A. Fluctuation spectroscopy in granular superconductors with application to boron-doped nanocrystalline diamond. *Phys. Rev. B* **104**, 094513 (2021).
3. Varlamov, A. A., Galda, A. & Glatz, A. Fluctuation spectroscopy: From Rayleigh–Jeans waves to Abrikosov vortex clusters. *Rev. Mod. Phys.* **90**, 015009 (2018).
4. Shapira, Y. & Deutscher, G. Semiconductor-superconductor transition in granular Al-Ge. *Phys. Rev. B* **27**, 4463–4466 (1983).
5. Deutscher, G., Entin-Wohlman, O., Fishman, S. & Shapira, Y. Percolation description of granular superconductors. *Phys. Rev. B* **21**, 5041–5047 (1980).
6. Lerner, I. V., Varlamov, A. A. & Vinokur, V. M. Fluctuation spectroscopy of granularity in superconducting structures. *Phys. Rev. Lett.* **100**, 117003 (2008).
7. Dauzhenka, T. A., Ksenevich, V. K., Bashmakov, I. A. & Galibert, J. Origin of negative magnetoresistance in polycrystalline SnO₂ films. *Phys. Rev. B* **83**, 165309 (2011).
8. Altshuler, B. L., Aronov, A. G. & Lee, P. A. Interaction effects in disordered Fermi systems in two dimensions. *Phys. Rev. Lett.* **44**, 1288–1291 (1980).
9. Lee, P. A. & Ramakrishnan, T. V. Disordered electronic systems. *Rev. Mod. Phys.* **57**, 287–337 (1985).
10. Lee, P. A. & Ramakrishnan, T. V. Magnetoresistance of weakly disordered electrons. *Phys. Rev. B* **26**, 4009–4012 (1982).
11. Aslamasov, L. G. & Larkin, A. I. The influence of fluctuation pairing of electrons on the conductivity of normal metal. *Phys. Lett. A* **26**, 238–239 (1968).
12. Maki, K. Critical fluctuation of the order parameter in a superconductor. *Prog. Theor. Phys.* **40**, 193–200 (1968).
13. Thompson, R. S. Microwave, flux flow, and fluctuation resistance of dirty type-II superconductors. *Phys. Rev. B* **1**, 327–333 (1970).

14. Giannouri, M., Papastaikoudis, C. & Rosenbaum, R. Low-temperature transport properties of Nb_{1-x}Ta_x thin films. *Phys. Rev. B* **59**, 4463–4469 (1999).
15. Annett, J. F. Theory of fluctuations in superconductors. *Phys. Today* **59**, 56–56 (2006).
16. Larkin, A. I. & Varlamov, A. A. In *Superconductivity: Conventional and Unconventional Superconductors* (eds Bennemann, K. H. & Ketterson, J. B.) 369–458 (Springer, 2008).
17. Baturina, T. I. *et al.* Superconducting phase transitions in ultrathin TiN films. *Europhys. Lett.* **97**, 17012 (2012).
18. Santhanam, P., Chi, C. C., Wind, S. J., Brady, M. J. & Bucchignano, J. J. Resistance anomaly near the superconducting transition temperature in short aluminum wires. *Phys. Rev. Lett.* **66**, 2254–2257 (1991).
19. Moshchalkov, V. V., Gielen, L., Neuttiens, G., Van Haesendonck, C. & Bruynseraede, Y. Intrinsic resistance fluctuations in mesoscopic superconducting wires. *Phys. Rev. B* **49**, 15412–15415 (1994).
20. Crusellas, M. A., Fontcuberta, J. & Piñol, S. Giant resistive peak close to the superconducting transition in L_{2-x}Ce_xCuO₄ single crystals. *Phys. Rev. B* **46**, 14089–14094 (1992).
21. Wang, Y.-L. *et al.* Parallel magnetic field suppresses dissipation in superconducting nanostrips. *Proc. Natl. Acad. Sci.* **114**, E10274–E10280 (2017).
22. Postolova, S. V., Mironov, A. Y., Baklanov, M. R., Vinokur, V. M. & Baturina, T. I. Reentrant resistive behavior and dimensional crossover in disordered superconducting TiN films. *Sci. Rep.* **7**, 1718 (2017).
23. Zhang, G., Zeleznik, M., Vanacken, J., May, P. W. & Moshchalkov, V. V. Metal-bosonic insulator–superconductor transition in boron-doped granular diamond. *Phys. Rev. Lett.* **110**, 077001 (2013).
24. Parendo, K. A., Tan, K. H. S. B. & Goldman, A. M. Evolution towards superconductivity in granular films of bismuth. *Phys. Rev. B* **76**, 100508 (2007).
25. Chudinov, S. M., Ferretti, R., Fusari, S., Mancini, G. & Stizza, S. Reentrant superconductivity mechanisms in amorphous carbon-silicon films containing tungsten. *Phys. Rev. B* **62**, 12516–12521 (2000).
26. Lin, T. H. *et al.* Observation of a reentrant superconducting resistive transition in granular BaPb_{0.75}Bi_{0.25}O₃ superconductor. *Phys. Rev. B* **29**, 1493–1496 (1984).
27. Zhang, G. *et al.* Bosonic anomalies in boron-doped polycrystalline diamond. *Phys. Rev. Appl.* **6**, 064011 (2016).
28. Hadacek, N., Sanquer, M. & Villégier, J. C. Double reentrant superconductor-insulator transition in thin TiN films. *Phys. Rev. B* **69**, 024505 (2004).
29. Gerber, A., Grenet, T., Cyrot, M. & Beille, J. Double-peak superconducting transition in granular L-M-Cu-O(L=Pr, Nd, Sm, Eu, D; M=Ce, Th) superconductors. *Phys. Rev. Lett.* **65**, 3201–3204 (1990).
30. Yadav, S., Kaushik, V., Saravanan, M. P. & Sahoo, S. Probing electron-electron interaction along with superconducting fluctuations in disordered TiN thin films. *Phys. Rev. B* **107**, 014511 (2023).
31. Sacépé, B. *et al.* Pseudogap in a thin film of a conventional superconductor. *Nat. Commun.* **1**, 140 (2010).
32. Baturina, T. I., Strunk, C., Baklanov, M. R. & Satta, A. Quantum metallicity on the high-field side of the superconductor-insulator transition. *Phys. Rev. Lett.* **98**, 127003 (2007).
33. Tikhonov, K. S., Schwiete, G. & Finkelstein, A. M. Fluctuation conductivity in disordered superconducting films. *Phys. Rev. B* **85**, 174527 (2012).
34. Galitski, V. M. & Larkin, A. I. Superconducting fluctuations at low temperature. *Phys. Rev. B* **63**, 174506 (2001).
35. Sambandamurthy, G., Engel, L., Johansson, A. & Shahar, D. J. Superconductivity-related insulating behavior. *Phys. Rev. Lett.* **92**, 107005 (2004).
36. Baturina, T. I., Mironov, A. Y., Vinokur, V. M., Baklanov, M. R. & Strunk, C. Localized superconductivity in the quantum-critical region of the disorder-driven superconductor-insulator transition in TiN thin films. *Phys. Rev. Lett.* **99**, 257003 (2007).
37. Xiong, P., Herzog, A. V. & Dynes, R. C. Negative magnetoresistance in homogeneous amorphous superconducting Pb wires. *Phys. Rev. Lett.* **78**, 927–930 (1997).
38. Gerber, A., Milner, A., Deutscher, G., Karpovsky, M. & Gladkikh, A. Insulator-superconductor transition in 3D granular Al-Ge films. *Phys. Rev. Lett.* **78**, 4277–4280 (1997).
39. Mironov, A. Y. *et al.* Charge Berezinskii-Kosterlitz–Thouless transition in superconducting NbTiN films. *Sci. Rep.* **8**, 4082 (2018).
40. Mitra, S., Tewari, G. C., Mahalu, D. & Shahar, D. Negative magnetoresistance in amorphous indium oxide wires. *Sci. Rep.* **6**, 37687 (2016).
41. Wang, L. *et al.* Magnetotransport properties in high-quality ultrathin two-dimensional superconducting Mo₂C crystals. *ACS Nano* **10**, 4504–4510 (2016).
42. Beloborodov, I. S. & Efetov, K. B. Negative magnetoresistance of granular metals in a strong magnetic field. *Phys. Rev. Lett.* **82**, 3332–3335 (1999).
43. Bergmann, G. Weak localization in thin films: A time-of-flight experiment with conduction electrons. *Phys. Rep.* **107**, 1–58 (1984).
44. Chiquito, A. J., Lanfredi, A. J. C., de Oliveira, R. F. M., Pozzi, L. P. & Leite, E. R. Electron dephasing and weak localization in Sn doped In₂O₃ nanowires. *Nano Lett.* **7**, 1439–1443 (2007).
45. Wang, J. *et al.* Observation of coexisting weak localization and superconducting fluctuations in strained Sn_{1-x}In_xTe thin films. *Nano Lett.* **22**, 792–800 (2022).
46. Zhang, E. *et al.* Magnetic-field-induced Re-entrance of superconductivity in Ta₂Pd₅S nanostraps. *Nano Lett.* **21**, 288–297 (2021).
47. Parendo, K. A., Hernandez, L. M., Bhattacharya, A. & Goldman, A. M. Anomalous parallel-field negative magnetoresistance in ultrathin films near the superconductor-insulator transition. *Phys. Rev. B* **70**, 212510 (2004).
48. Lopes dos Santos, J. M. B. & Abrahams, E. Superconducting fluctuation conductivity in a magnetic field in two dimensions. *Phys. Rev. B* **31**, 172–176 (1985).
49. Glatz, A., Varlamov, A. A. & Vinokur, V. M. Quantum fluctuations and dynamic clustering of fluctuating Cooper pairs. *Europhys. Lett.* **94**, 47005 (2011).
50. Brighi, P., Grilli, M., Leridon, B. & Caprara, S. Effect of anomalous diffusion of fluctuating Cooper pairs on the density of states of superconducting NbN thin films. *Phys. Rev. B* **100**, 174518 (2019).
51. Tan, K. H. S. B., Parendo, K. A. & Goldman, A. M. Evidence of spatially inhomogeneous pairing on the insulating side of a disorder-tuned superconductor-insulator transition. *Phys. Rev. B* **78**, 014506 (2008).
52. Dai, J. & Tang, J. Weak localization and magnetoresistance of island-like thin copper films. *J. Appl. Phys.* **92**, 6047–6050 (2002).
53. Rosenbaum, R. Superconducting fluctuations and magnetoconductance measurements of thin films in parallel magnetic fields. *Phys. Rev. B* **32**, 2190–2199 (1985).
54. Yadav, S. *et al.* Substrate mediated synthesis of Ti–Si–N nano-and-micro structures for optoelectronic applications. *Adv. Eng. Mater.* **21**, 1900061 (2019).
55. Yadav, S. *et al.* A robust nitridation technique for fabrication of disordered superconducting TiN thin films featuring phase slip events. *Sci. Rep.* **11**, 7888 (2021).
56. Yadav, S. & Sahoo, S. Interface study of thermally driven chemical kinetics involved in Ti/Si₃N₄ based metal-substrate assembly by X-ray photoelectron spectroscopy. *Appl. Surf. Sci.* **541**, 148465 (2021).

Acknowledgements

The central facilities from CSIR-NPL used for the present study are highly acknowledged. We thankfully acknowledge Dr. Sandeep Singh for the AFM characterization. We are thankful to Dr. Sudhir Husale for his critical reading of the manuscript and also for his invaluable suggestions on the manuscript. S.Y. acknowledges the Senior Research Fellowship (SRF) from UGC. Authors acknowledge the financial support for establishing the dilution refrigerator facility at CSIR-NPL from the Department of Science and Technology (DST), Govt. of India, under the project, SR/52/pu-0003/2010(G). This work was supported by CSIR network project 'AQuaRIUS' (Project No. PSC 0110) and is carried out under the mission mode project "Quantum Current Metrology" (Project No. HCP-55).

Author contributions

S.Y. and S.S. prepared the devices. S.Y. and S.S. performed the low temperature transport measurements on the devices. R.P.A. provided the technical support during the low temperature measurements. G.G. supported the XPS characterization and helped in analyzing the data. S.Y. and S.S. analyzed the data and prepared the manuscript.

Competing interests

The authors declare no competing interests.

Additional information

Supplementary Information The online version contains supplementary material available at <https://doi.org/10.1038/s41598-023-50091-7>.

Correspondence and requests for materials should be addressed to S.S.

Reprints and permissions information is available at www.nature.com/reprints.

Publisher's note Springer Nature remains neutral with regard to jurisdictional claims in published maps and institutional affiliations.



Open Access This article is licensed under a Creative Commons Attribution 4.0 International License, which permits use, sharing, adaptation, distribution and reproduction in any medium or format, as long as you give appropriate credit to the original author(s) and the source, provide a link to the Creative Commons licence, and indicate if changes were made. The images or other third party material in this article are included in the article's Creative Commons licence, unless indicated otherwise in a credit line to the material. If material is not included in the article's Creative Commons licence and your intended use is not permitted by statutory regulation or exceeds the permitted use, you will need to obtain permission directly from the copyright holder. To view a copy of this licence, visit <http://creativecommons.org/licenses/by/4.0/>.

© The Author(s) 2023